

# 3.3V LVDS 1:4 Clock Fanout Buffer AK8181G

### Features

- Four differential 3.3V LVDS outputs
- Selectable two LVCMOS/LVTTL clock inputs

**Preliminary** 

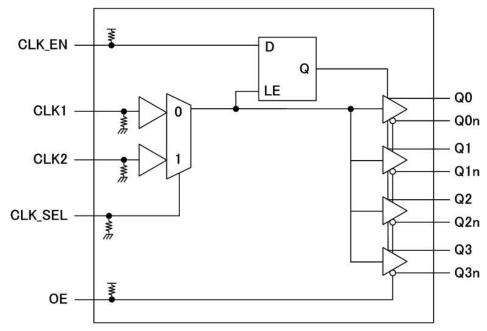
- Clock output frequency up to 650MHz
- Translates LVCMOS/LVTTL input signals to LVDS levels
- Output skew : 30ps (maximum)
- Part-to-part skew : 500ps (maximum)
- Propagation delay : 2.2ns (maximum)
- Additive phase jitter(RMS): 0.1ps (typical)
- Operating Temperature Range: -40 to +85°C
- Package: 20-pin TSSOP (Pb free)
- Pin compatible with ICS8545I

### Description

The AK8181G is a member of AKM's LVDS clock fanout buffer family designed for telecom, networking and computer applications, requiring a range of clocks with high performance and low skew. The AK8181G distributes 4 buffered clocks.

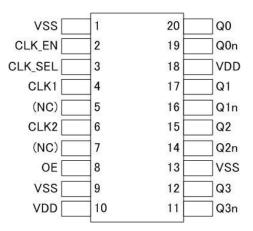
AK8181G are derived from AKM's long-termexperienced clock device technology, and enable clock output to perform low skew. The AK8181G is available in a 20-pin TSSOP package.

### **Block Diagram**





### **Pin Descriptions**



Package: 20-Pin TSSOP(Top View)

Pin No.	Pin Name	Pin Type	Pullup down	Description
1	VSS	PWR		Negative power supply
2	CLK_EN	IN	Pull up	Synchronizing clock output enable (LVCMOS/LVTTL) Pin is connected to VDD by internal resistor. (typ. $51k\Omega$ ) High (Open): clock outputs follow clock input. Low: Q outputs are forced low, Qn outputs are forced high.
3	CLK_SEL	IN	Pull down	CLK Select Input (LVCMOS/LVTTL) Pin is connected to VSS by internal resistor. (typ. $51k\Omega$ ) High: selects CLK2 input Low (Open): selects CLK1 input
4	CLK1	IN	Pull down	Single-ended clock input Pin is connected to VSS by internal resistor. (typ. $51k\Omega$ )
5	NC			No connect
6	CLK2	IN	Pull down	Single-ended clock input Pin is connected to VSS by internal resistor. (typ. $51k\Omega$ )
7	NC			No connect
8	OE	IN	Pull up	Output enable. Controls enabling and disabling of outputs Q0, Q0n through Q3, Q3n. Pin is connected to VDD by internal resistor. (typ. $51k\Omega$ )
9	VSS	PWR		Negative power supply
10	VDD	PWR		Positive power supply
11, 12	Q3n, Q3	OUT		Differential clock output (LVDS)
13	VSS	PWR		Negative power supply
14, 15	Q2n, Q2	OUT		Differential clock output (LVDS)
16, 17	Q1n, Q1	OUT		Differential clock output (LVDS)
18	VDD	PWR		Positive power supply
19, 20	Q0n, Q0	OUT		Differential clock output (LVDS)

### **Ordering Information**

Part Number	Marking	Shipping Packaging	Package	Temperature Range
AK8181G	AK8181G	Tape and Reel	20-pin TSSOP	-40 to 85 °C



### **Absolute Maximum Rating**

Over operating free-air temperature	range unless	otherwise noted <sup>(1)</sup>
	range unless	

Items	Symbol	Ratings	Unit
Supply voltage	VDD	-0.3 to 4.6	V
Input voltage	Vin	VSS-0.5 to VDD+0.5	V
Input current (any pins except supplies)	I <sub>IN</sub>	±10	mA
Storage temperature	Tstg	-55 to 150	°C

Note

(1) Stress beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only. Functional operation of the device at these or any other conditions beyond those indicated under "Recommended Operating Conditions" is not implied. Exposure to absolute-maximum-rating conditions for extended periods may affect device reliability. Electrical parameters are guaranteed only over the recommended operating temperature range.

(2) VSS=0V



### **ESD Sensitive Device**

This device is manufactured on a CMOS process, therefore, generically susceptible to damage by excessive static voltage. Failure to observe proper handling and installation procedures can cause damage. AKM recommends that this device is handled with appropriate precautions.

#### **Recommended Operation Conditions**

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Operating temperature	Та		-40		85	°C
Supply voltage <sup>(1)</sup>	VDD	VDD±5%	3.135	3.3	3.465	V

(1) Power of 3.3V requires to be supplied from a single source. A decoupling capacitor of  $0.1 \mu F$  for power supply line should be located close to each VDD pin.

### **Pin Characteristics**

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Input Capacitance	CIN			4		pF
Input Pullup Resistor	R <sub>PU</sub>			51		kΩ
Input Pulldown Resistor	R <sub>PD</sub>			51		kΩ

### **Power Supply Characteristics**

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
		CLK1 = input 650MHz			47	mA
	I <sub>DD</sub>	CLK2 = open			47	ША
Power Supply Current		CLK1 = open			47	
		CLK2 = input 650MHz			47	mA



## DC Characteristics (LVCMOS/LVTTL)

All specifications at VDD=3.3V±5%, Ta: -40 to +85°C, unless otherwise noted

Param	eter	Symbol	Conditions	MIN	ТҮР	МАХ	Unit
Input High Voltage		V <sub>IH</sub>		2.0		VDD+0.3	V
	CLK1, CLK2			-0.3		1.3	V
Input Low Voltage	CLK_SEL, OE, CLK_EN,	V <sub>IL</sub>		-0.3		0.8	V
In put Lliph Current	CLK_SEL		Vin=VDD=3.465V			150	μA
Input High Current	CLK_EN, OE	Ι <sub>Η</sub>	Vin=VDD=3.465V			5	μA
	CLK_SEL		Vin=VSS, VDD=3.465V	-5			μΑ
Input Low Current	CLK_EN, OE	ΙL	Vin=VSS, VDD=3.465V	-150			μA

### **DC** Characteristics (Differential)

All specifications at VDD=3.3V±5%, VSS=0V, Ta: -40 to +85°C, unless otherwise noted

Parameter	Symbol	Conditions	MIN	ТҮР	MAX	Unit
Differential Output Voltage	V <sub>OD</sub>		200	280	360	mV
V <sub>OD</sub> Magnitude Change	$\Delta V_{OD}$				40	mV
Offset Voltage	Vos		1.125	1.25	1.375	V
Vos Magnitude Change	ΔVos			5	25	mV
High Impedance Leakage Current	I <sub>OZ</sub>	OE = Low	-10		+10	μA
Differential Output Short Circuit Current	IOSD			-3.5	-5	mA
Output Voltage High	V <sub>OH</sub>			1.34	1.6	V
Output Voltage Low	V <sub>OL</sub>		0.9	1.06		V



### **AC Characteristics**

All specifications at VDD=3.3V±5%, VSS=0V, Ta: -40 to +85°C, unless otherwise noted

Parameter	Symbol	Conditions	MIN	TYP	MAX	Unit
Output Frequency	f <sub>OUT</sub>				650	MHz
Propagation Delay <sup>(1)</sup>	t <sub>PD</sub>		0.7		2.2	ns
Output Skew (2) (3)	t <sub>sk(O)</sub>				30	ps
Part-to-Part Skew (3) (4)	t <sub>skPP</sub>				500	ps
Buffer Additive Jitter, RMS <sup>(5)</sup>	t <sub>jit</sub>	156.25MHz (12kHz – 20MHz)		0.1		ps
Output Rise/Fall Time (5)	t <sub>r</sub> , t <sub>f</sub>	20% to 80% @50MHz	100		500	ps
Output Duty Cycle	DC <sub>OUT</sub>		45		55	%

All parameters measured at f  $\leq$  650MHz unless noted otherwise.

The cycle to cycle jitter on the input will equal the jitter on the output. The part does not add jitter.

(1) Measured from VDD/2 of the input to the differential output crossing point.

(2) Defined as skew between outputs at the same supply voltage and with equal load conditions.

(3) This parameter is defined in accordance with JEDEC Standard 65.

(4) Defined as skew between outputs on different devices operating at the same supply voltages and with equal load conditions. Using the same type of inputs on each device, the outputs are measured at the differential cross points.

(5) Design value.



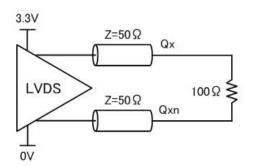


Figure 1 3.3V Output Load Test Circuit

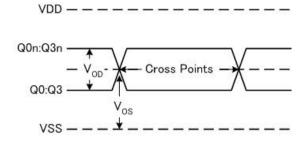
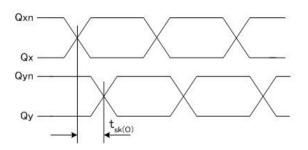


Figure 2 Differential Output Level





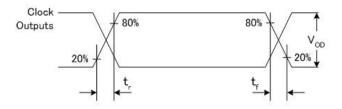
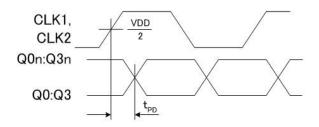
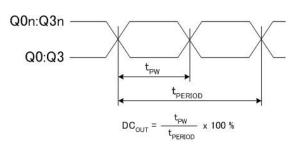


Figure 4 Output Rise/Fall Time









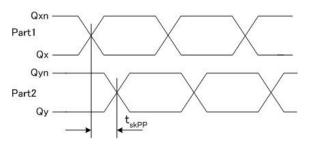
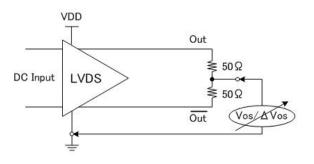


Figure 7 Part-to-Part Skew







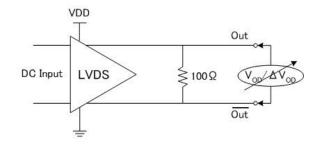
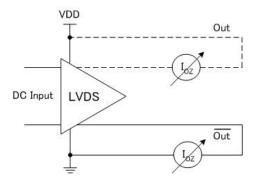


Figure 9 Differential Output Voltage Setup



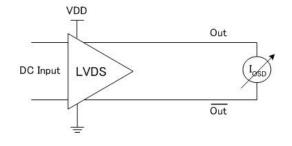


Figure 10 High Impedance Leakage Current Setup





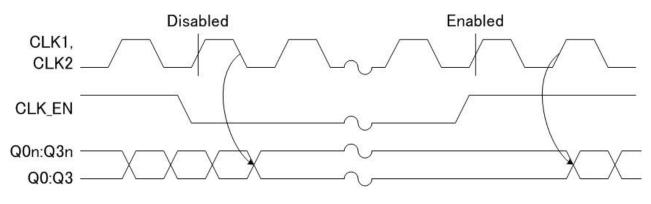
### **Function Table**

The following table shows the inputs/outputs clock state configured through the control pins.

		Inputs		Outputs		
OE	CLK_EN	CLK_SEL	Selected Source	Q0:Q3	Q0n:Q3n	
1	0	0 (Open)	CLK1	Disabled: Low	Disabled: High	
1	0	1	CLK2	Disabled: Low	Disabled: High	
1	1 (Open)	0 (Open)	CLK1	Enabled	Enabled	
1	1 (Open)	1	CLK2	Enabled	Enabled	
0	Don't care	Don't care		Hi-Z	Hi-Z	

#### **Table 1: Control Input Function Table**

After CLK\_EN switches, the clock outputs are disabled or enabled following a rising and falling input clock edge as shown in Figure 12. In the active mode, the state of the outputs are a function of the CLK1 and CLK2 inputs as described in Table 2.



### Figure 12 CLK\_EN Timing Diagram

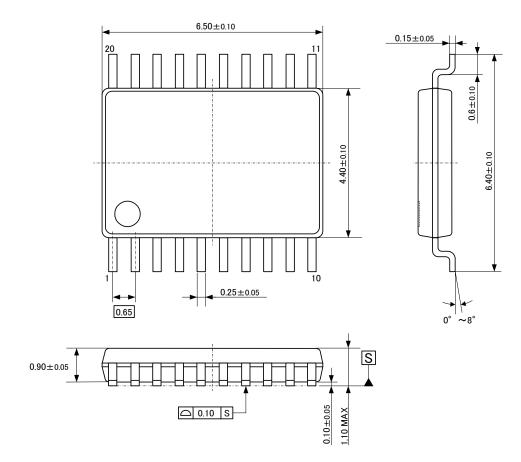
Inputs	Outputs			
CLK1/2	Q0 : Q3	Q0n : Q3n		
0	Low	High		
1	High	Low		

#### **Table 2: Clock Input Function Table**

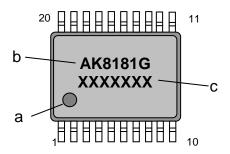


### **Package Information**

### • Mechanical data : 20pin TSSOP



• Marking



- a: #1 Pin Index
- b: Part number
- c: Date code (7 digits)

### • RoHS Compliance



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(\*) RoHS compliant products from AKM are identified with "Pb free" letter indication on product label posted on the anti-shield bag and boxes.



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